Application/Control No. O9/770,571 Examiner Philip C Lee Applicant(s)/Patent Under Reexamination TAWIL ET AL. Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,606,630	08-2003	Gunlock, Richard D.	707/100
	В	US-6,745,281	06-2004	Saegusa, Takuya	711/112
	C	US-6,665,714	12-2003	Blumenau et al.	709/222
	D	US-6,343,324	01-2002	Hubis et al.	709/229
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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